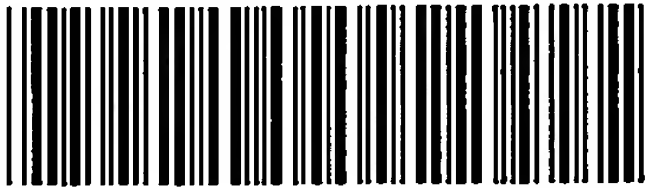


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/622,038	TAKAMURA, TAKASHI	
	Examiner	Art Unit	
	DiLinh Nguyen	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	737	1/4/05	DLN
	738		
	778		
	697		
257	698		
438	613-617		
	132		
438	601		
228	180.22	1/4/05	DLN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR